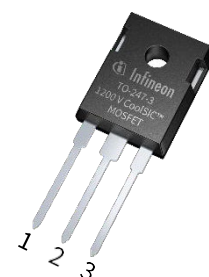
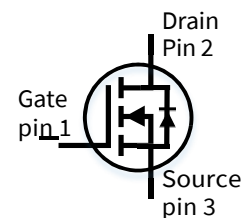


英飞凌CoolSiC™ 1200V SiC 沟槽 MOSFET

英飞凌碳化硅 MOSFET IMW120R045M1

特性

- 开关损耗非常低
- 无拐点导通特性
- 宽栅源电压范围
- 基准栅极阈值电压, $V_{GS(th)} = 4.5V$
- 0V turn-off gate voltage
- 完全可控的 dV/dt
- 换向稳健的体二极管, 可用于同步整流
- 关断损耗不受温度影响



优点

- 提高效率
- 实现更高的频率
- 增加功率密度
- 减少冷却工作量
- 降低系统复杂性和成本



潜在应用

- 能源生产
 - 光伏组串逆变器和光伏优化器
- 工业供电
 - 工业级不间断电源 (UPS)
 - 工业开关电源
- 基础设施 - 充电
 - 充电器



产品验证

符合JEDEC47/20/22相关测试的工业应用要求

表 1 主要性能及封装参数

Type	V_{DS}	I_D ($T_C = 25^\circ C, R_{th(j-c, max)}$)	$R_{DS(on)}$ ($T_{vj} = 25^\circ C, I_D = 20A, V_{GS} = 15V$)	$T_{j, max}$	Marking	Package
IMW120R045M1	1200V	52A	45mΩ	175°C	120M1045	PG-TO247-3

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最大额定值

1 最大额定值

注意：为了获得最佳的使用寿命和可靠性，英飞凌建议运行条件不超过本数据手册中所述最大额定值的 80%。

表 2 最大额定值

Parameter	Symbol	Value	Unit
Drain-source voltage, $T_{vj} \geq 25^{\circ}\text{C}$	V_{DS}	1200	V
DC drain current for $R_{th(j-c,max)}$, limited by T_{vjmax} , $V_{GS} = 15\text{V}$, $T_C = 25^{\circ}\text{C}$ $T_C = 100^{\circ}\text{C}$	I_D	52 36	A
Pulsed drain current, t_p limited by T_{vjmax} , $V_{GS} = 15\text{V}$	$I_{D,pulse1}$	130	A
DC body diode forward current for $R_{th(j-c,max)}$, limited by T_{vjmax} , $V_{GS} = 0\text{V}$ $T_C = 25^{\circ}\text{C}$ $T_C = 100^{\circ}\text{C}$	I_{SD}	52 28	A
Pulsed body diode current, t_p limited by T_{vjmax}	$I_{SD,pulse1}$	130	A
Gate-source voltage ² Max transient voltage, < 1% duty cycle Recommended turn-on gate voltage Recommended turn-off gate voltage	V_{GSS} $V_{GSS,on}$ $V_{GSS,off}$	-10... 20 15 0	V
Short-circuit withstand time $V_{DD} = 800\text{V}$, $V_{DS,peak} < 1200\text{V}$, $V_{GS,on} = 15\text{V}$, $T_{j,start} = 25^{\circ}\text{C}$	t_{SC}	3	μs
Power dissipation, limited by T_{vjmax} $T_C = 25^{\circ}\text{C}$ $T_C = 100^{\circ}\text{C}$	P_{tot}	228 114	W
Virtual junction temperature	T_{vj}	-55... 175	$^{\circ}\text{C}$
Storage temperature	T_{stg}	-55... 150	$^{\circ}\text{C}$
Soldering temperature, wavesoldering only allowed at leads, 1.6mm (0.063 in.) from case for 10 s	T_{sold}	260	$^{\circ}\text{C}$
Mounting torque, M3 screw Maximum of mounting processes: 3	M	0.6	Nm

¹经过设计验证

²**重要提示：**正、负栅极源电压的选择会影响器件的长期性能。为确保设备在计划使用寿命内正常运行，请务必研读 [《应用说明AN2018-09》](#) 中描述的设计指南。

2 热阻抗

表 3

Parameter	Symbol	Conditions	Value			Unit
			min.	typ.	max.	
MOSFET/body diode thermal resistance, junction – case	$R_{th(j-c)}$		-	0.51	0.66	K/W
Thermal resistance, junction – ambient	$R_{th(j-a)}$	leaded	-	-	62	K/W

电气特性

3 电气特性

3.1 静态特性

表 4 静态特性（测于 $T_{vj} = 25^{\circ}\text{C}$ 时，除非另有规定）

Parameter	Symbol	Conditions	Value			Unit
			min.	typ.	max.	
Drain-source on-state resistance	$R_{DS(on)}$	$V_{GS} = 15\text{V}, I_D = 20\text{A},$ $T_{vj} = 25^{\circ}\text{C}$ $T_{vj} = 100^{\circ}\text{C}$ $T_{vj} = 175^{\circ}\text{C}$	- - -	45 55 75	59 - -	$\text{m}\Omega$
Body diode forward voltage	V_{SD}	$V_{GS} = 0\text{V}, I_{SD} = 20\text{A}$ $T_{vj} = 25^{\circ}\text{C}$ $T_{vj} = 100^{\circ}\text{C}$ $T_{vj} = 175^{\circ}\text{C}$	- - -	4.1 4.0 3.9	5.2 - -	V
Gate-source threshold voltage	$V_{GS(th)}$	<i>(tested after 1 ms pulse at</i> $V_{GS} = 20\text{V})$ $I_D = 10\text{mA}, V_{DS} = V_{GS}$ $T_{vj} = 25^{\circ}\text{C}$ $T_{vj} = 175^{\circ}\text{C}$	3.5 -	4.5 3.6	5.7 -	V
Zero gate voltage drain current	I_{DSS}	$V_{GS} = 0\text{V}, V_{DS} = 1200\text{V}$ $T_{vj} = 25^{\circ}\text{C}$ $T_{vj} = 175^{\circ}\text{C}$	- -	2 4	200 -	μA
Gate-source leakage current	I_{GSS}	$V_{GS} = 20\text{V}, V_{DS} = 0\text{V}$	-	-	120	nA
		$V_{GS} = -10\text{V}, V_{DS} = 0\text{V}$	-	-	-120	nA
Transconductance	g_{fs}	$V_{DS} = 20\text{V}, I_D = 20\text{A}$	-	11.1	-	S
Internal gate resistance	$R_{G,int}$	$f = 1\text{MHz}, V_{AC} = 25\text{mV}$	-	4	-	Ω

3.2 动态特性

表 5 动态特性（测于 $T_{vj} = 25^{\circ}\text{C}$ ，除非另有规定）

Parameter	Symbol	Conditions	Value			Unit
			min.	typ.	max.	
Input capacitance	C_{iss}	$V_{DD} = 800\text{V}, V_{GS} = 0\text{V},$ $f = 1\text{MHz}, V_{AC} = 25\text{mV}$	-	1900	-	pF
Output capacitance	C_{oss}		-	115	-	
Reverse capacitance	C_{rss}		-	13	-	
C_{oss} stored energy	E_{oss}		-	44	-	μJ
Total gate charge	Q_G	$V_{DD} = 800\text{V}, I_D = 20\text{A},$ $V_{GS} = 0/15\text{V}, \text{turn-on pulse}$	-	52	-	nC
Gate to source charge	$Q_{GS,pl}$		-	15	-	
Gate to drain charge	Q_{GD}		-	13	-	

3.3 开关特性

表 6 开关特性，感性负载⁴

Parameter	Symbol	Conditions	Value			Unit
			min.	typ.	max.	

MOSFET 特性，测于 $T_{vj} = 25^{\circ}\text{C}$ 时

Turn-on delay time	$t_{d(on)}$	$V_{DD} = 800\text{V}, I_D = 20\text{A}, V_{GS} = 0/15\text{V}, R_{G,ext} = 2\Omega, L_{\sigma} = 40\text{nH},$ diode: body diode at $V_{GS} = 0\text{V}$ see Fig. E	-	9	-	ns
Rise time	t_r		-	24	-	
Turn-off delay time	$t_{d(off)}$		-	17	-	
Fall time	t_f		-	13	-	
Turn-on energy	E_{on}	body diode at $V_{GS} = 0\text{V}$ see Fig. E	-	350	-	μJ
Turn-off energy	E_{off}		-	70	-	
Total switching energy	E_{tot}		-	420	-	

体二极管特性，测于 $T_{vj} = 25^{\circ}\text{C}$ 时

Diode reverse recovery charge	Q_{rr}	$V_{DD} = 800\text{V}, I_{SD} = 20\text{A},$ V_{GS} at diode = $0\text{V},$ $di/dt = 1000\text{A}/\mu\text{s},$ Q_{rr} includes also $Q_C,$ see Fig. C	-	0.15	-	μC
Diode peak reverse recovery current	I_{rrm}		-	8	-	A

MOSFET Characteristics, $T_{vj} = 175^{\circ}\text{C}$

 T_{vj}

Turn-on delay time	$t_{d(on)}$	$V_{DD} = 800\text{V}, I_D = 20\text{A}, V_{GS} = 0/15\text{V}, R_{G,ext} = 2\Omega, L_{\sigma} = 40\text{nH},$ diode: body diode at $V_{GS} = 0\text{V}$ see Fig. E	-	9	-	ns
Rise time	t_r		-	24	-	
Turn-off delay time	$t_{d(off)}$		-	20	-	
Fall time	t_f		-	14	-	
Turn-on energy	E_{on}	body diode at $V_{GS} = 0\text{V}$ see Fig. E	-	380	-	μJ
Turn-off energy	E_{off}		-	75	-	
Total switching energy	E_{tot}		-	455	-	

体二极管特性，测于 $T_{vj} = 175^{\circ}\text{C}$ 时

Diode reverse recovery charge	Q_{rr}	$V_{DD} = 800\text{V}, I_{SD} = 20\text{A},$ V_{GS} at diode = $0\text{V},$ $di/dt = 1000\text{A}/\mu\text{s},$ Q_{rr} includes also $Q_C,$ see Fig. C	-	0.25	-	μC
Diode peak reverse recovery current	I_{rrm}		-	10	-	A

⁴ 该芯片技术的特征斜率高达 $200\text{ kV}/\mu\text{s}$ 。测量的 dV/dt 受到测量测试设置和封装的限制。

电气特性图

4 电气特性图

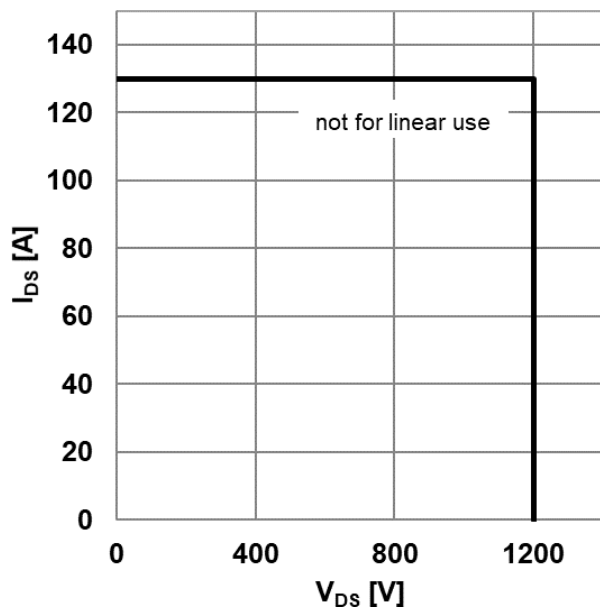


Figure 1 Reverse bias safe operating area (RBSOA) ($V_{GS} = 0/15V$, $T_C = 25^\circ C$, $T_J < 175^\circ C$)

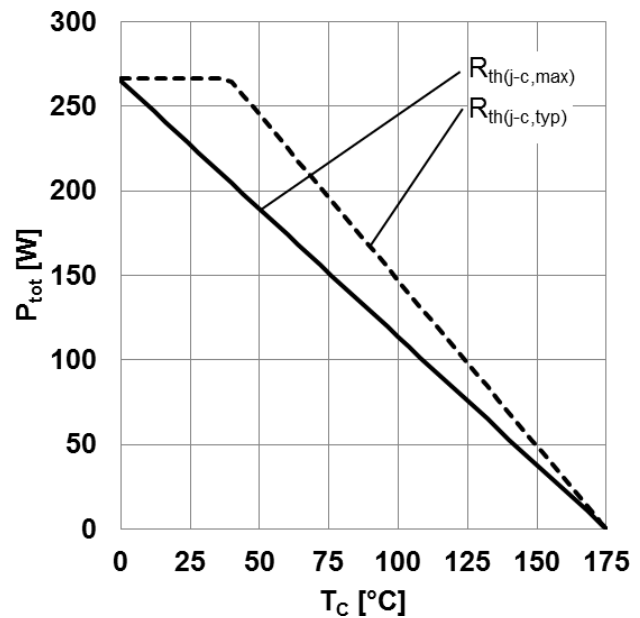


Figure 2 Power dissipation as a function of case temperature limited by bond wire
($P_{tot} = f(T_C)$)

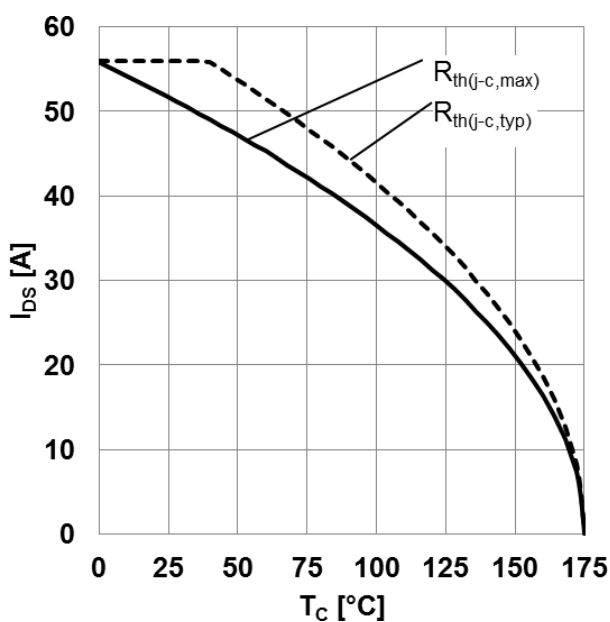


Figure 3 Maximum DC drain to source current as a function of case temperature limited by bond wire ($I_{DS} = f(T_C)$)

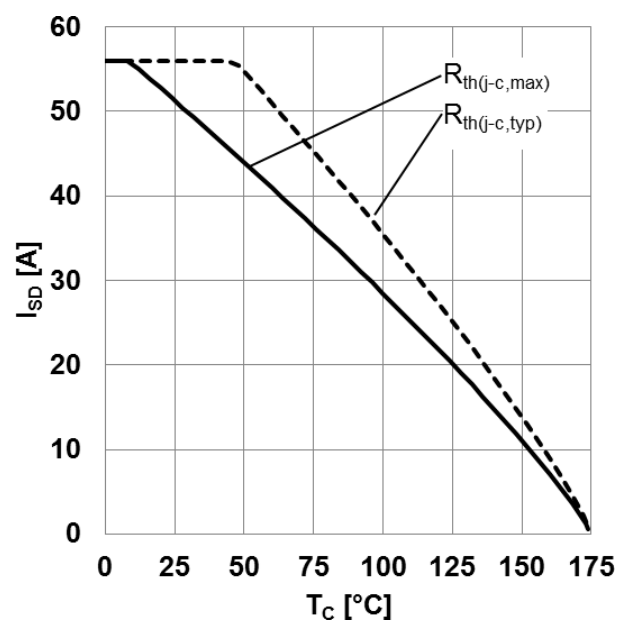


Figure 4 Maximum source to drain current as a function of case temperature limited by bond wire ($I_{SD} = f(T_C)$, $V_{GS} = 0V$)

电气特性图

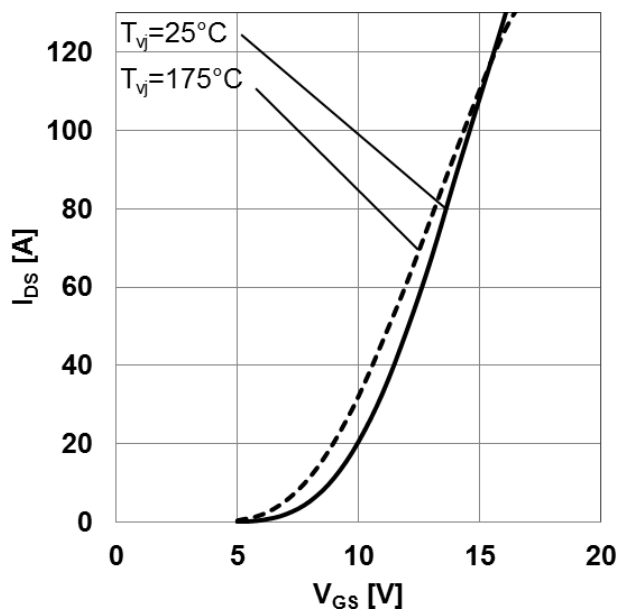


Figure 5 Typical transfer characteristic
 $(I_{DS} = f(V_{GS}), V_{DS} = 20V, t_P = 20\mu s)$

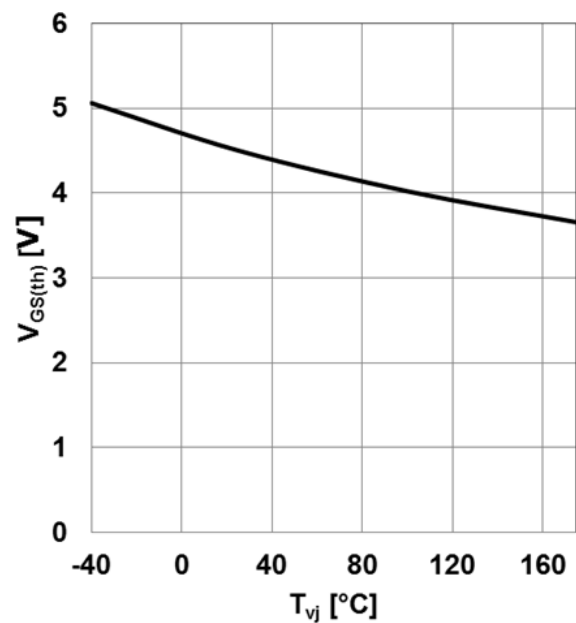


Figure 6 Typical gate-source threshold voltage as a function of junction temperature
 $(V_{GS(th)} = f(T_{vj}), I_{DS} = 10mA, V_{GS} = V_{DS})$

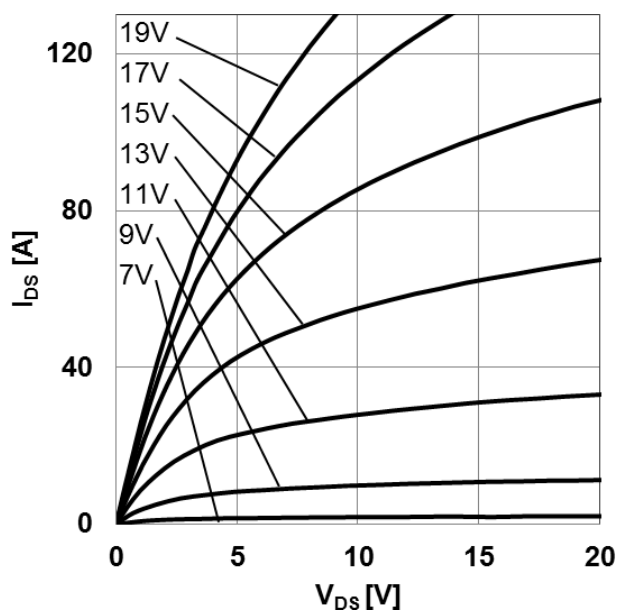


Figure 7 Typical output characteristic, V_{GS} as parameter
 $(I_{DS} = f(V_{DS}), T_{vj} = 25^\circ C, t_P = 20\mu s)$

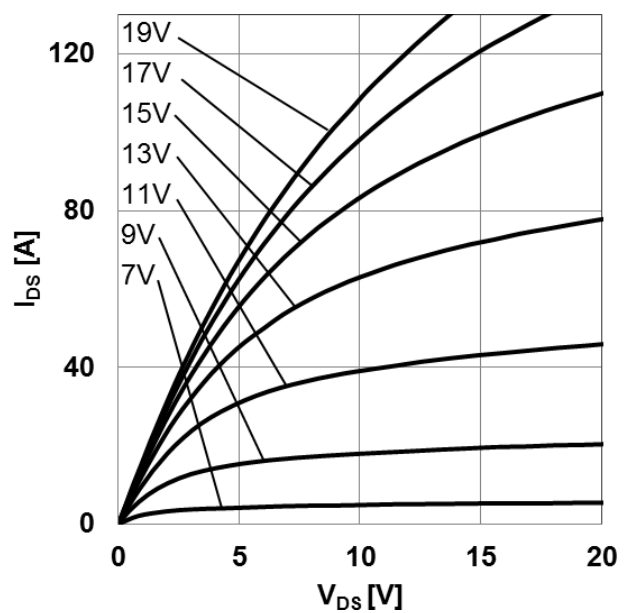


Figure 8 Typical output characteristic, V_{GS} as parameter
 $(I_{DS} = f(V_{DS}), T_{vj} = 175^\circ C, t_P = 20\mu s)$

电气特性图

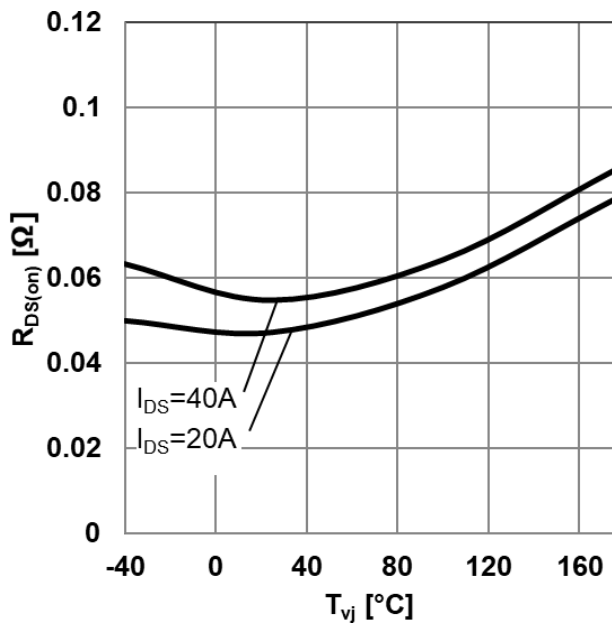


Figure 9 Typical on-resistance as a function of junction temperature
 $(R_{DS(on)} = f(T_{vj}), V_{GS}=15V)$

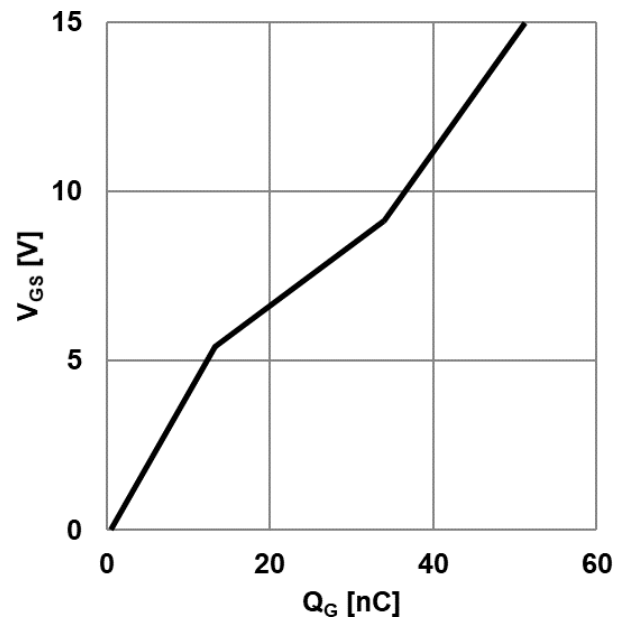


Figure 10 Typical gate charge ($V_{GS}=f(Q_G)$, $I_{DS}=20A$, $V_{DS}=800V$, turn-on pulse)

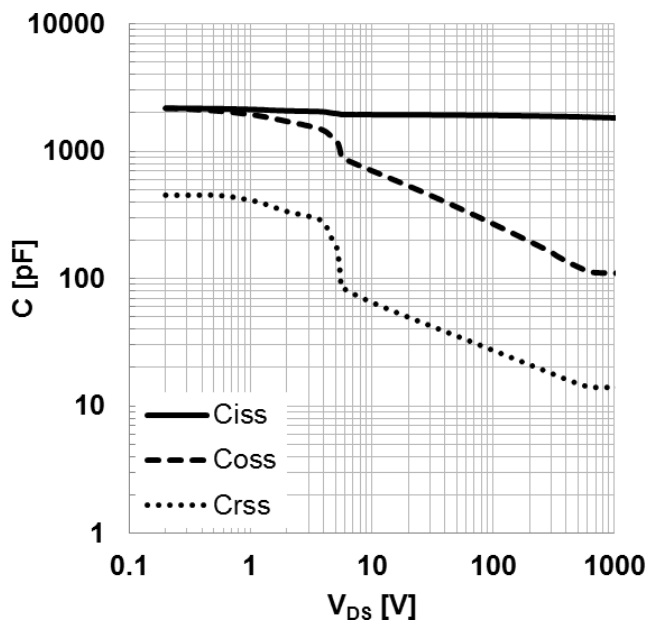


Figure 11 Typical capacitance as a function of drain-source voltage
 $(C = f(V_{DS}), V_{GS}=0V, f=1MHz)$

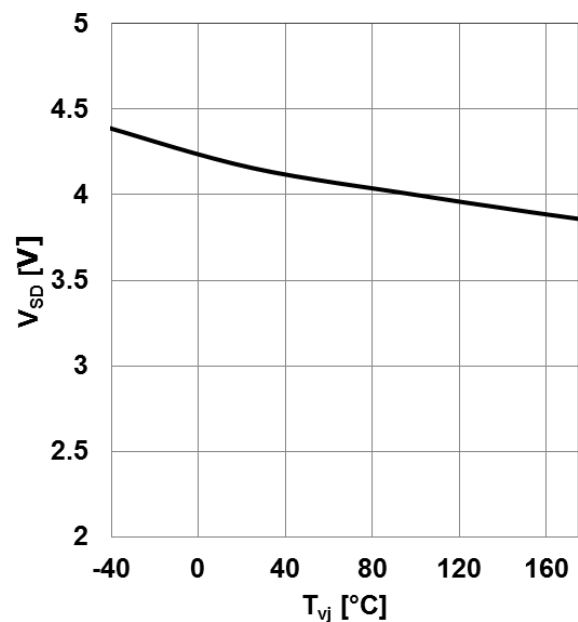


Figure 12 Typical body diode forward voltage as function of junction temperature
 $(V_{SD}=f(T_{vj}), V_{GS}=0V, I_{SD}=20A)$

电气特性图

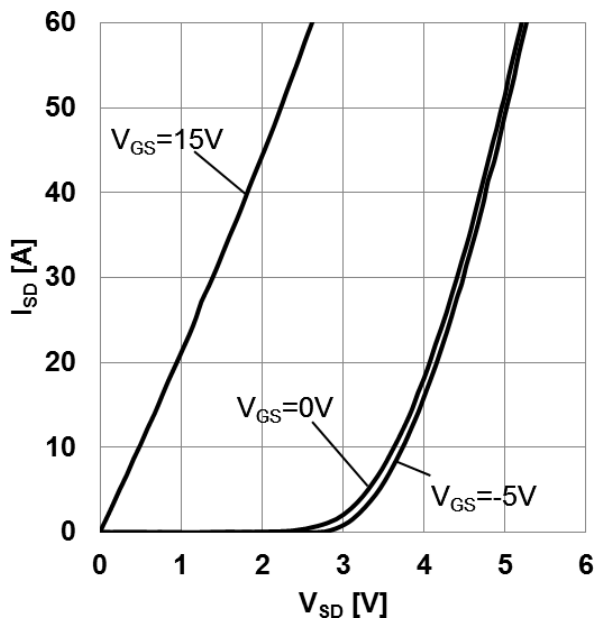


Figure 13 Typical body diode forward current as function of forward voltage, V_{GS} as parameter

($I_{SD} = f(V_{SD})$, $T_{vj} = 25^\circ\text{C}$, $t_P = 20\mu\text{s}$)

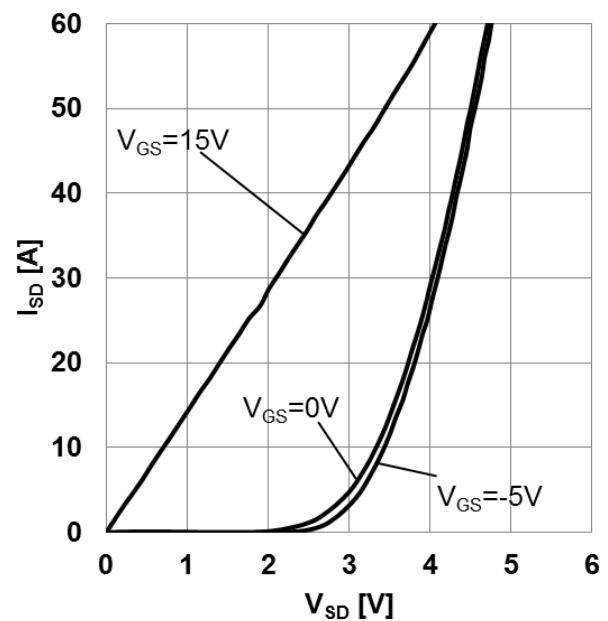


Figure 14 Typical body diode forward current as function of forward voltage, V_{GS} as parameter

($I_{SD} = f(V_{SD})$, $T_{vj} = 175^\circ\text{C}$, $t_P = 20\mu\text{s}$)

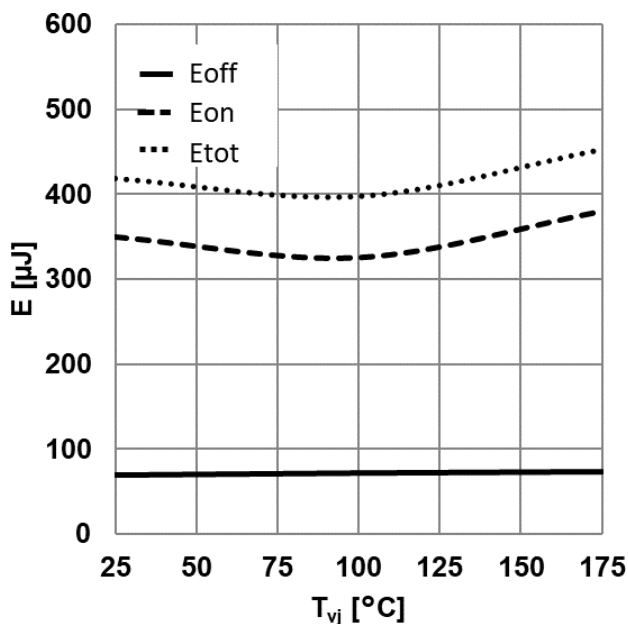


Figure 15 Typical switching energy losses as a function of junction temperature

($E = f(T_{vj})$, $V_{DD} = 800\text{V}$, $V_{GS} = 0\text{V}/15\text{V}$, $R_{G,ext} = 2\Omega$, $I_D = 20\text{A}$, ind. load, test circuit in Fig. E, diode: body diode)

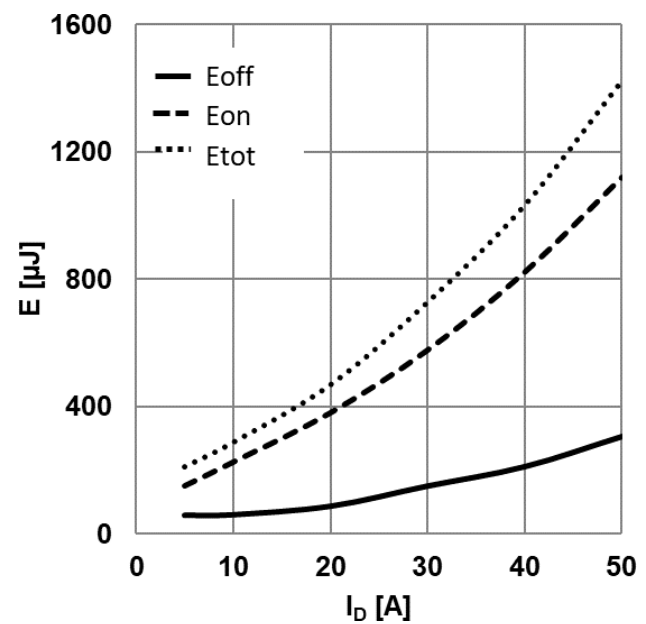


Figure 16 Typical switching energy losses as a function of drain-source current

($E = f(I_{DS})$, $V_{DD} = 800\text{V}$, $V_{GS} = 0\text{V}/15\text{V}$, $R_{G,ext} = 2\Omega$, $T_{vj} = 175^\circ\text{C}$, ind. load, test circuit in Fig. E, diode: body diode)

电气特性图

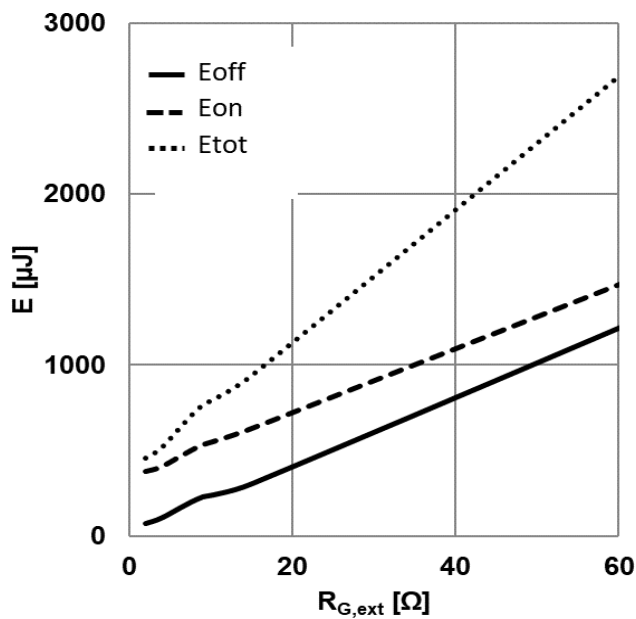


Figure 17 Typical switching energy losses as a function of gate resistance
 $(E = f(R_{G,ext}), V_{DD} = 800V, V_{GS} = 0V/15V, I_D = 20A, T_{vj} = 175^\circ C, \text{ind. load, test circuit in Fig. E, diode: body diode})$

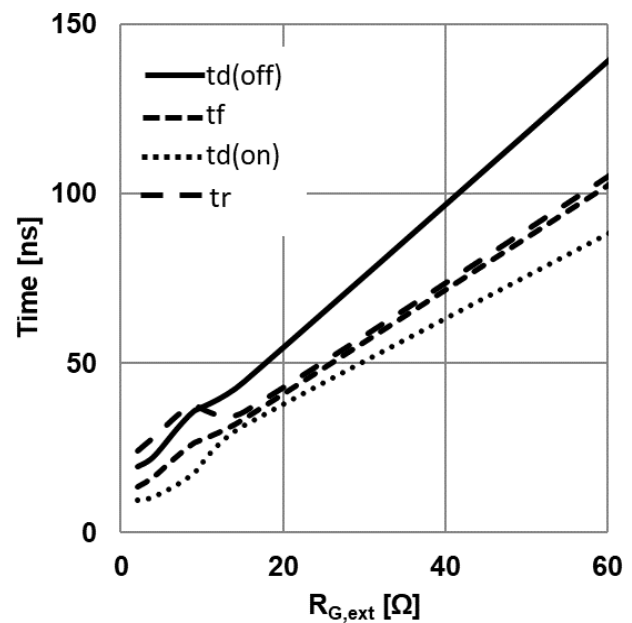


Figure 18 Typical switching times as a function of gate resistor
 $(t = f(R_{G,ext}), V_{DD} = 800V, V_{GS} = 0V/15V, I_D = 20A, T_{vj} = 175^\circ C, \text{ind. load, test circuit in Fig. E, diode: body diode})$

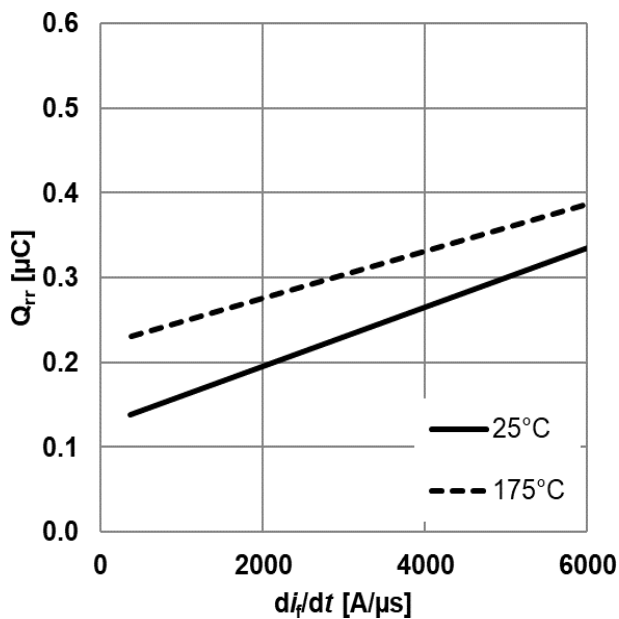


Figure 19 Typical reverse recovery charge as a function of diode current slope
 $(Q_{rr} = f(di_t/dt), V_{DD} = 800V, I_D = 20A, \text{ind. load, test circuit in Fig. E})$

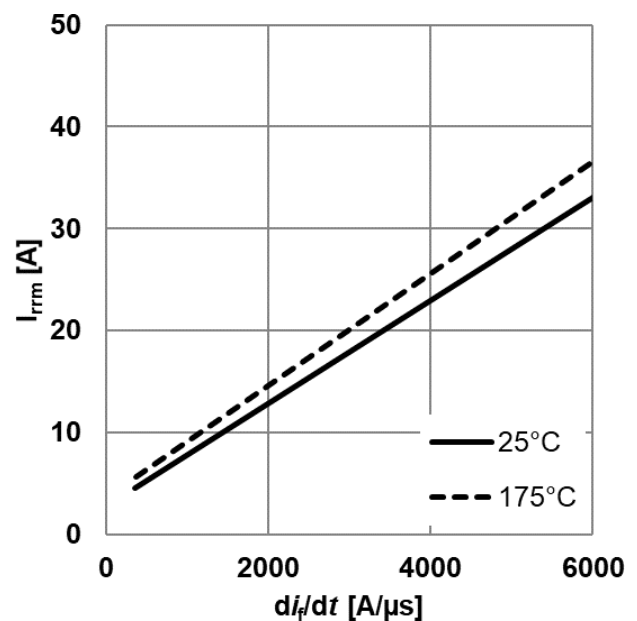


Figure 20 Typical reverse recovery current as a function of diode current slope
 $(I_{rrm} = f(di_t/dt), V_{DD} = 800V, I_D = 20A, \text{ind. load, test circuit in Fig. E})$

电气特性图

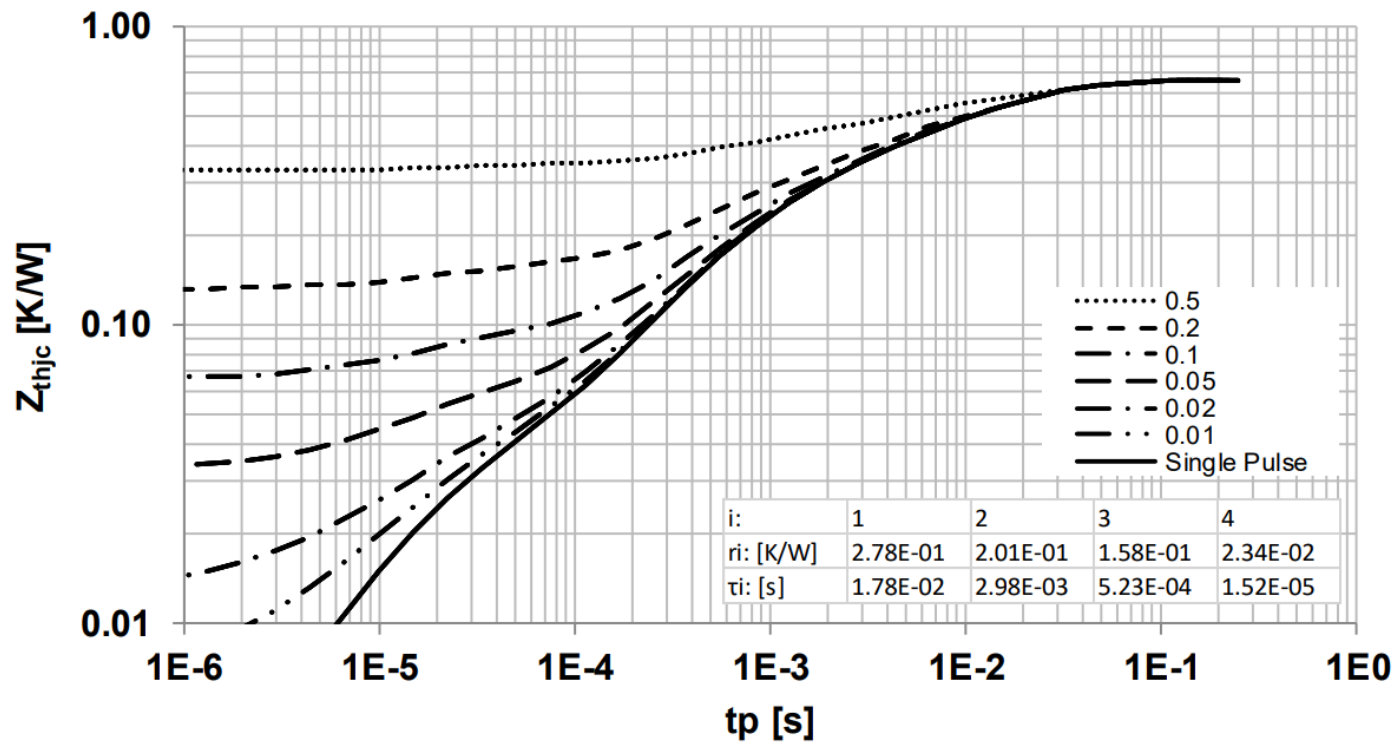


图 21 最大瞬态热阻 (MOSFET/二极管)

($Z_{th(jc,max)} = f(t_p)$, 参数 $D = t_p / T$, 热等效电路见图 D)

封装图

5 封装图

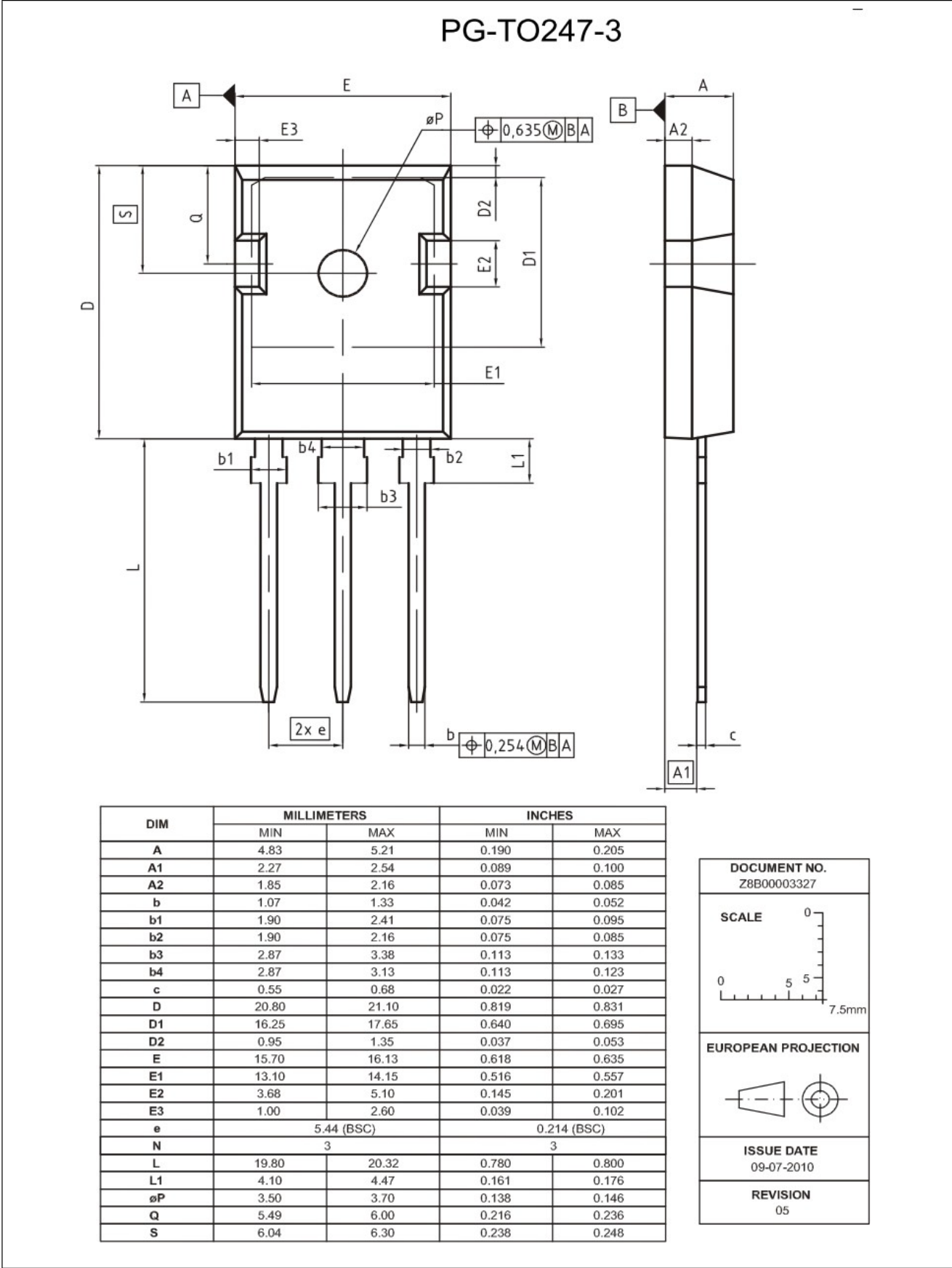


图 22 封装图

测试条件

6 测试条件

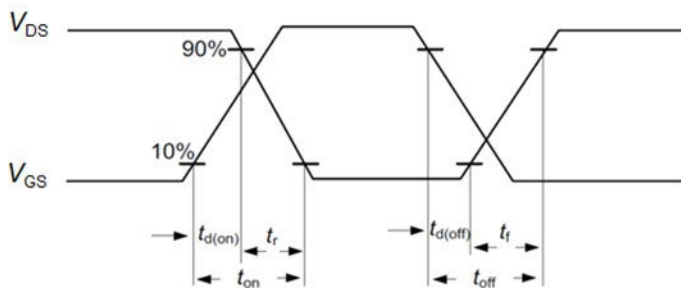


Figure A. Definition of switching times

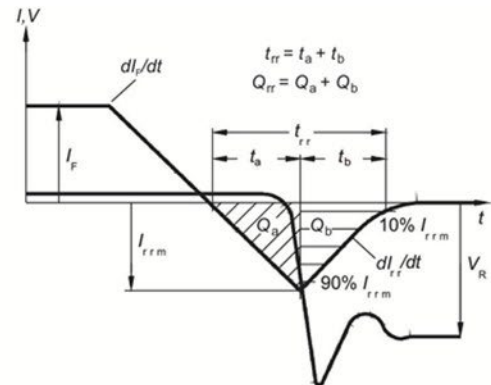


Figure C. Definition of diode switching characteristics

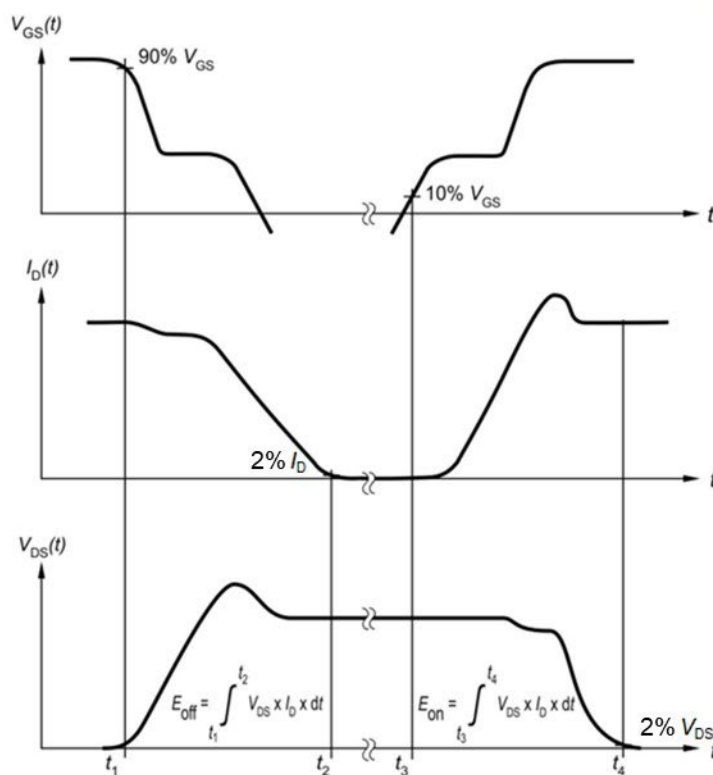


Figure B. Definition of switching losses

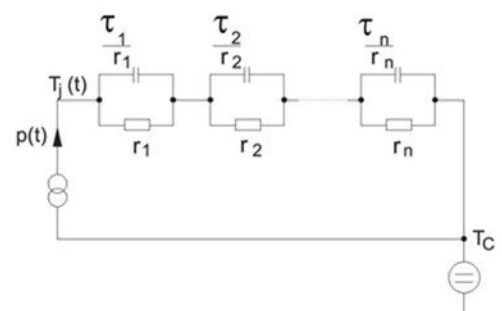


Figure D. Thermal equivalent circuit

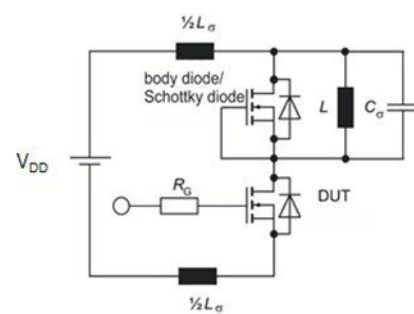


Figure E. Dynamic test circuit

Parasitic inductance L_{σ} ,
parasitic capacitor C_{σ} ,

图 23 测试条件

修订记录

修订记录

自上次修订以来的主要变化

Document version	Date of release	Description of changes
2.1	2018-03-01	Initial version
2.2	2018-05-30	Important footnote update in chapter 1 Change of conditions for switching dynamic characteristics in chapter 3.2 and 3.3 Additional figures for $V_{GS}=0V/15V$ in chapter 4
2.3	2019-04-18	Add Recommended gate voltage in chapter 1 Add SOA figure in chapter 4 Figures removed for $V_{GS}=-5V/15V$ in chapter 4
2.4	2019-12-10	Move the short circuit time from dynamic characteristics table 5 to maximum ratings table 2. Update the Figure 21 Zth curve.
2.5	2020-06-12	Correction of marking letters in table 1
2.6	2020-12-11	Correction of circuit symbol on page 1



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